# 4-Bit Differential ECL Bus to TTL Bus Transceiver

The MC10H/100H680 is a dual supply 4-bit differential ECL bus to TTL bus transceiver. It is designed to allow the system designer to no longer be limited in bus speed associated with standard TTL busses. Using a differential ECL Bus will increase the frequency of operation and increase noise immunity.

Both the TTL and the ECL ports are capable of driving a bus. The ECL outputs have the ability to drive 25  $\Omega$ , allowing both ends of the bus line to be terminated in the characteristic impedance of 50  $\Omega$ . The TTL outputs are specified to source 15 mA and sink 48 mA, allowing the ability to drive highly capacitive loads.

The ECL output levels are  $V_{OH}$  approximately equal to -1.0 V and  $V_{OL}$  cutoff equal to -2.0~V~(VTT). When the ECL ports are disabled both EIOx and EIOxB go to the VOL cutoff level. The ECL input receivers have special circuitry which detects this disabled condition, prevents oscillation, and forces the TTL output to the low state. The noise margin in this disabled state is greater than 600 mV. Multiple ECL V<sub>CCO</sub> pins are utilized to minimize switching noise.

The TTL ports have standard levels. The TTL input receivers have PNP input devices to significantly reduce loading. Multiple TTL power and ground pins are utilized to minimize switching noise.

The control pins (EDIR and ECEB) of the 10H version is compatible with MECL<sup>TM</sup> 10H ECL logic levels. The control pins of the 100H version are compatible with 100K levels.

- Differential ECL Bus (25 Ω) I/O Ports
- High Drive TTL Bus I/O Ports
- Extra TTL and ECL Power/Ground Pins to Minimize Switching Noise
- Dual Supply

March, 2004 - Rev. 9

• Direction and Chip Enable Control Pins



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PLCC-28 **FN SUFFIX CASE 776** 



**MARKING** 

Α = Assembly Location

WL = Wafer Lot = Year \/\/\/ = Work Week

#### ORDERING INFORMATION

Device	Package	Shipping
MC10H680FN	PLCC-28	37 Units/Rail
MC100H680FN	PLCC-28	37 Units/Rail

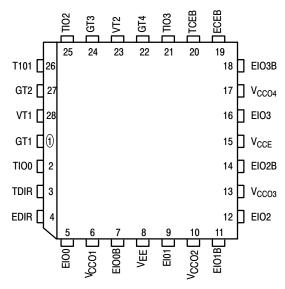


Figure 1. Pinout: PLCC-28 (Top View)

**Table 1. PIN DESCRIPTIONS** 

	I III DEGGI	
Pin	Symbol	Function
1	GT1	TTL Ground 1
2	TIO0	TTL I/O Bit 0
3	TDIR	TTL Direction Control
4	EDIR	ECL Direction Control
5	EIO0	ECL I/O Bit 0
6	VCCO1	ECL V <sub>CC</sub> 1 (0 V) – Outputs
7	EIO0B	ECL I/O Bit 0 Bar
8	$V_{EE}$	ECL Supply (-5.2/-4.5 V)
9	EIO1	ECL I/O Bit 1
10	VCCO2	ECL V <sub>CC</sub> 2 (0 V) – Outputs
11	EIO1B	ECL I/O Bit 1 Bar
12	EIO2	ECL I/O Bit 2
13	VCCO3	ECL V <sub>CC</sub> 3 (0 V) – Outputs
14	EIO2B	ECL I/O Bit 2 Bar
15	$V_{CCE}$	ECL V <sub>CC</sub> (0 V)
16	EIO3	ECL I/O Bit 3
17	VCCO4	ECL V <sub>CC</sub> 4 (0 V) – Outputs
18	EIO3B	ECL I/O Bit 3 Bar
19	ECEB	ECL Chip Enable Bar Control
20	TCEB	TTL Chip Enable Bar Control
21	TIO3	TTL I/O Bit 3
22	GT4	TTL Ground 4
23	VT2	TTL Supply 2 (5.0 V)
24	GT3	TTL Ground 3
25	TIO2	TTL I/O Bit 2
26	TIO1	TTL I/O Bit 1
27	GT2	TTL Ground 2
28	VT1	TTL Supply 1 (5.0 V)

ECEB - Chip Enable Bar Control ECL Levels

#### **Table 2. TRUTH TABLE**

TDIR – Direction Control TTL Levels EDIR – Direction Control ECL Levels TCEB – Chip Enable Bar Control TTL Levels

Levels TIN – TTL Input
Levels TOUT – TTL Output
rol TTL Levels EIN – ECL Input

EINB – ECL Input Bar EOUT – ECL Output EOUTB – ECL Output Bar

ECEB	TCEB	EDIR	TDIR	EIN	EINB	EOUT	EOUTB	TIN	TOUT	COMMENTS
Н	Х	Х	Х	Х	Х	LC	LC	Х	Z	ECL and TTL Outputs Disabled
Х	Н	Х	Х	Х	Х	LC	LC	Х	Z	ECL and TTL Outputs Disabled
L	L	Н	Х	Н	LC			NA	Н	ECL to TTL Direction
L	L	Н	Х	LC	Н			NA	L	ECL to TTL Direction
L	L	Н	Х	LC	LC			NA	L	ECL to TTL Direction (L-L Condition)
L	L	Х	Н	Н	LC			NA	Н	ECL to TTL Direction
L	L	Х	Н	LC	Н			NA	L	ECL to TTL Direction
L	L	Х	Н	LC	LC			NA	L	ECL to TTL Direction (L-L Condition)
L	L	L	L	NA	NA	Н	LC	Н		TTL to ECL Direction
L	L	L	L	NA	NA	LC	Н	L		TTL to ECL Direction

H – HIGH

L – LOW

LC - ECL Low Cutoff (VTT = -2.0 V)

X - Don't Care

Z - High Impedance

Table 3. ABSOLUTE RATINGS (Do not exceed):

Power Supply Voltage	V <sub>EE</sub> (ECL)	-8.0 to 0	Vdc
Power Supply Voltage	V <sub>CCT</sub> (TTL)	-0.5 to +7.0	Vdc
Input Voltage	V <sub>I</sub> (ECL) V <sub>I</sub> (TTL)	0.0 to V <sub>EE</sub> -0.5 to +7.0	Vdc
Disabled 3-State Output	V <sub>out</sub> (TTL)	0.0 to V <sub>CCT</sub>	Vdc
Output Source Current Continuous	I <sub>out</sub> (ECL)	100	mAdc
Output Source Current Surge	I <sub>out</sub> (ECL)	200	mAdc
Storage Temperature	T <sub>stg</sub>	-65 to 150	°C
Operating Temperature	T <sub>amb</sub>	0.0 to +75	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

#### Table 4. ECL DC CHARACTERISTICS:

 $V_{CCT}$  = +5.0 V ±10%,  $V_{EE}$  = -5.2 ±5% (10H Version);  $V_{EE}$  = -4.2 V to -5.5 V (100H Version)

			T <sub>A</sub> =	T <sub>A</sub> = 0°C		T <sub>A</sub> = 25°C		T <sub>A</sub> = 75°C	
Symbol	Parameter	Condition	Min	Max	Min	Max	Min	Max	Unit
IEE	Supply Current/ECL			-110		-110		-110	mA
I <sub>INH</sub>	Input HIGH Current			255		175		175	μΑ
I <sub>INL</sub>	Input LOW Current		0.5		0.5		0.3		μΑ
V <sub>OH</sub> V <sub>OL</sub>	Output HIGH Voltage Output LOW Voltage	25 Ω to –2.1 V	-1100 -2.1	-840 -2.03	-1100 -2.1	-810 -2.03	-1100 -2.1	-735 -2.03	mV V

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

### Table 5. CONTROL INPUTS ONLY, 10H ECL DC CHARACTERISTICS:

 $V_{CCT} = +5.0 \pm 10\%, V_{EE} = -5.2 \pm 5\%$ 

		$T_A = 0^{\circ}C$		T <sub>A</sub> = 25°C		T <sub>A</sub> = 75°C		
Symbol	Parameter	Min	Max	Min	Max	Min	Max	Unit
V <sub>IH</sub> V <sub>IL</sub>	Input HIGH Voltage Input LOW Voltage	-1170 -1950	-840 -1480	-1130 -1950	-810 -1480	-1070 -1950	-735 -1450	mV

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

#### Table 6. CONTROL INPUTS ONLY, 100H ECL DC CHARACTERISTICS:

 $V_{CCT} = +5.0 \pm 10\%$ ,  $V_{EE} = -4.2 \text{ V to } -5.5 \text{ V}$ 

		T <sub>A</sub> = 0°C		T <sub>A</sub> = 25°C		T <sub>A</sub> = 75°C		
Symbol	Parameter	Min	Max	Min	Max	Min	Max	Unit
V <sub>IH</sub> V <sub>IL</sub>	Input HIGH Voltage Input LOW Voltage	-1165 -1810	-880 -1475	-1165 -1810	-880 -1475	-1165 -1810	-880 -1475	mV

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

#### **Table 7. TTL DC CHARACTERISTICS:**

 $V_{CCT}$  = +5.0 V ±10%,  $V_{EE}$  = -5.2 ±5% (10H Version);  $V_{EE}$  = -4.2 V to -5.5 V (100H Version)

			T <sub>A</sub> =	$T_A = 0^{\circ}C$		25°C	T <sub>A</sub> =	75°C	
Symbol	Parameter	Condition	Min	Max	Min	Max	Min	Max	Unit
V <sub>IH</sub> V <sub>IL</sub>	Standard Input Standard Input		2.0	0.8	2.0	0.8	2.0	0.8	Vdc
V <sub>IK</sub>	Input Clamp	I <sub>IN</sub> = -18 mA		-1.2		-1.2		-1.2	Vdc
V <sub>OH</sub>	Output HIGH Voltage Output HIGH Voltage	$I_{OH} = -3.0 \text{ mA}$ $I_{OH} = -15 \text{ mA}$	2.5 2.0		2.5 2.0		2.5 2.0		V
V <sub>OL</sub>	Output LOW Voltage	I <sub>OL</sub> = 48 mA		0.55		0.55		0.55	V
I <sub>IH</sub> *	TTL (Input HIGH) TTL (Input HIGH)	V <sub>in</sub> = 2.7 V V <sub>in</sub> = 7.0 V		20 100		20 100		20 100	μΑ
I <sub>IL</sub> *	TTL (Input LOW)	V <sub>in</sub> = 0.5 V		-0.6		-0.6		-0.6	mA
I <sub>CCL</sub>	Supply Current			75		75		75	mA
I <sub>CCH</sub>	Supply Current			70		70		70	mA
I <sub>CCZ</sub>	Supply Current			70		70		70	mA
Ios	Output Short Circuit Current	V <sub>OUT</sub> = 0 V	-100	-225	-100	-225	-100	-225	mA

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

#### Table 8. TTL I/O DC CHARACTERISTICS ONLY

			T <sub>A</sub> =	0°C	T <sub>A</sub> =	25°C	T <sub>A</sub> =	75°C	
Symbol	Parameter	Condition	Min	Max	Min	Max	Min	Max	Unit
I <sub>IH/IOZH</sub> I <sub>IL/IOZL</sub>	Output Disable Current	$V_{OUT} = 2.7 \text{ V}$ $V_{OUT} = 0.5 \text{ V}$		70 200		70 200		70 200	μΑ

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

<sup>\*</sup>TTL Control Inputs only

Table 9. ECL TO TTL DIRECTION / AC TEST

				T <sub>A</sub> =	0°C	T <sub>A</sub> =	25°C	T <sub>A</sub> =	75°C	
Symbol	Parameter	Waveforms	Condition	Min	Max	Min	Max	Min	Max	Unit
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay to Output	2, 4	C <sub>L</sub> = 50 pF	2.7	4.8	2.7	4.8	2.7	4.8	ns
t <sub>PZH</sub> t <sub>PZL</sub>	ECEB to Output Enable Time	2, 5, 6	C <sub>L</sub> = 50 pF	3.5 3.5	6.5 6.0	3.5 3.5	6.5 6.0	3.7 3.7	6.7 6.4	ns
t <sub>PHZ</sub>	ECEB to Output Disable Time	2, 5, 6	C <sub>L</sub> = 50 pF	3.5 3.5	8.6 6.5	3.5 3.5	8.6 6.5	3.7 3.7	8.8 7.3	ns
t <sub>PZH</sub>	TCEB to Output Enable Time	2, 5, 6	C <sub>L</sub> = 50 pF	5.7 5.4	7.7 6.9	5.7 5.4	7.7 6.9	5.9 5.9	7.9 7.4	ns
t <sub>PHZ</sub>	TCEB to Output Disable Time	2, 5, 6	C <sub>L</sub> = 50 pF	4.0 4.0	8.5 5.8	4.1 4.2	8.4 6.0	4.2 4.7	8.3 6.5	ns
t <sub>r</sub> /t <sub>f</sub>	1.0 to 2.0 Vdc	3	C <sub>L</sub> = 50 pF	0.4	1.5	0.4	1.5	0.4	1.5	ns

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

Table 10. TTL TO ECL DIRECTION / AC TEST

				T <sub>A</sub> =	0°C	T <sub>A</sub> = 1	25°C	T <sub>A</sub> =	75°C	
Symbol	Parameter	Waveforms	Condition	Min	Max	Min	Max	Min	Max	Unit
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay to Output	1, 4	25 Ω to –2.0 V	1.8	4.6	1.8	4.6	2.0	4.9	ns
t <sub>PLH</sub> t <sub>PHL</sub>	ECEB to Output	1, 4	25 Ω to –2.0 V	2.9	5.1	3.0	5.2	3.4	5.7	ns
t <sub>PLH</sub> t <sub>PHL</sub>	TCEB to Output	1, 4	25 Ω to –2.0 V	3.4	6.3	3.5	6.6	3.8	7.4	ns
t <sub>r</sub> /t <sub>f</sub>	Output Rise/Fall Time 20% – 80%	1, 3	25 Ω to –2.0 V	1.0	3.4	1.0	3.4	1.0	3.4	ns

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

#### **CONTROL INPUTS**

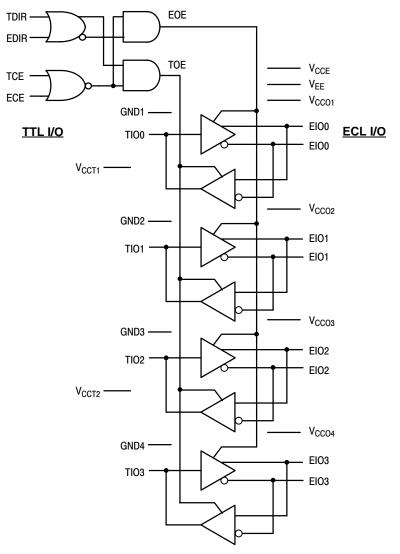


Figure 2. Block Diagram

#### **SWITCHING CIRCUIT**

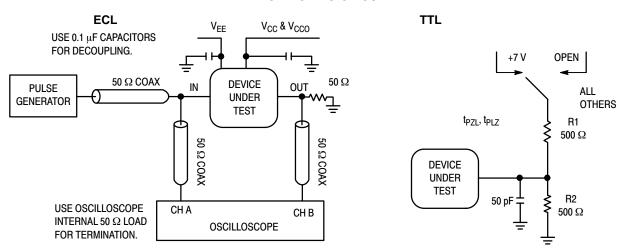


Figure 3. Switching Circuit ECL

Figure 4.

#### **WAVEFORMS**

#### **ECL/TTL**

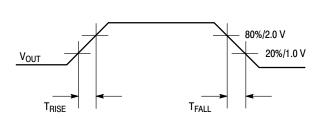


Figure 5. WAVEFORMS: Rise and Fall Times

#### **ECL/TTL**

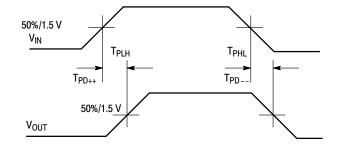


Figure 6. Propagation Delay - Single Ended

#### TTL

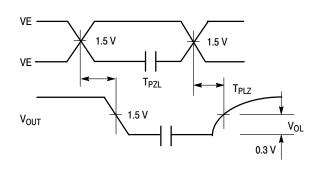


Figure 7. 3-State Output Low Enable and **Disable Times** 

#### TTL

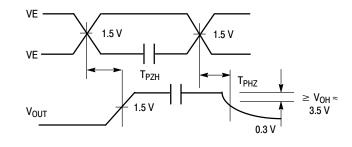


Figure 8. 3-State Output High Enable and Disable Times

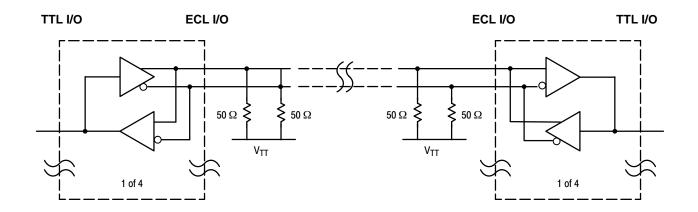


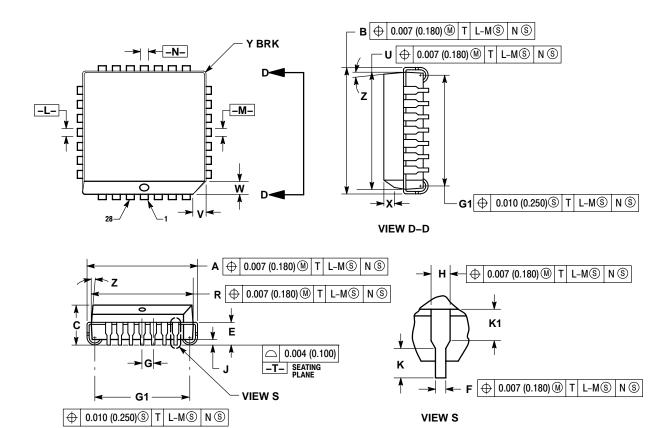
Figure 9. ECL I/O Link Application Recommended Termination

(Directional Control Intentionally Excluded)

#### PACKAGE DIMENSIONS

#### PLCC-28 **FN SUFFIX**

PLASTIC PLCC PACKAGE CASE 776-02 **ISSUE E** 



- NOTES:
  1. DATUMS -L-, -M-, AND -N- DETERMINED WHERE TOP OF LEAD SHOULDER EXITS PLASTIC BODY AT MOLD PARTING LINE.
- PLASTIC BODY AT MOLD PARTING LINE.

  2. DIMENSION G1, TRUE POSITION TO BE MEASURED AT DATUM -T-, SEATING PLANE.

  3. DIMENSIONS R AND U DO NOT INCLUDE MOLD FLASH ALLOWABLE MOLD FLASH IS 0.010 (0.250) PER SIDE.

  4. DIMENSIONING AND TOLERANCING PER ANSI YLA EM 1929.

- 4. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  5. CONTROLLING DIMENSION: INCH.
  6. THE PACKAGE TOP MAY BE SMALLER THAN THE PACKAGE BOTTOM BY UP TO 0.012 (0.300). DIMENSIONS R AND U ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY

  TOLLING OF MAD LANGUE TO A PROPERTY. EXCLUSIVE OF MOLD FLASH, TIE BAR BURRS, GATE BURRS AND INTERLEAD FLASH, BUT INCLUDING ANY MISMATCH BETWEEN THE TOP AND BOTTOM OF THE
- BE I WEEN THE TOP AND BOTTOM OF THE PLASTIC BODY.

  7. DIMENSION H DOES NOT INCLUDE DAMBAR PROTRUSION OR INTRUSION. THE DAMBAR PROTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE GREATER THAN 0.037 (0.940). THE DAMBAR INTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE SMALLER THAN 0.025 (0.635).

	INC	HES	MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.485	0.495	12.32	12.57
В	0.485	0.495	12.32	12.57
С	0.165	0.180	4.20	4.57
Е	0.090	0.110	2.29	2.79
F	0.013	0.019	0.33	0.48
G	0.050	BSC	1.27	BSC
Н	0.026	0.032	0.66	0.81
7	0.020		0.51	
K	0.025		0.64	
R	0.450	0.456	11.43	11.58
U	0.450	0.456	11.43	11.58
٧	0.042	0.048	1.07	1.21
W	0.042	0.048	1.07	1.21
Χ	0.042	0.056	1.07	1.42
Υ		0.020		0.50
Z	2°	10°	2°	10°
G1	0.410	0.430	10.42	10.92
K1	0.040		1.02	

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